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A Review of GaN MMIC Power Amplifier Technologies for Millimeter-Wave Applications

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SUMMARY GaN microwave monolithic integrated circuit (MMIC) power amplifiers (PAs) technologies for millimeter-wave (mm-wave) applications are reviewed in this paper. In the mm-wave band, GaN PAs have achieved high-output power as much as traveling wave tube amplifiers used in satellite communications. Additionally, GaN PAs have been integrated enough to be used for 5G and Beyond-5G. In this paper, a high accuracy large-signal GaN-HEMT modeling technique including the trapping effects is introduced in mm-waves. The prototyped PAs designed with the novel modeling technique have achieved RF performance comparable to that of the state-of-the-art GaN PAs in mm-wave.

key words: GaN, SATCOM, 5G, high power amplifier, MMIC, Doherty amplifier, millimeter wave

1. Introduction

In recent years, GaN technology is widely used in microwave applications and its operating frequency limit is expanding to millimeter-wave (mm-wave). In the satellite communication (SATCOM) systems, K and Ka-bands (18 to 40 GHz) are used to meet the demand for a high data rate [1], [2]. In 5G mobile systems [3], [4], a large system capacity, low latency, and massive connection will be provided for various applications according with 1000 times mobile traffic that is predicted in early 2020 compared with that of 2010. For this system, mm-wave massive multiple-input multiple-output (m-MIMO) is a promising technology [5]. Mm-wave 5G mobile systems, so called Frequency Range 2 (FR2), is expected to realize new communication services using large capacity and high throughput with the SATCOM [6].

Traveling wave tube amplifiers (TWTAs) are generally used as transmitters in mm-waves, because of their high power and high efficiency performances. On the other hand, it is difficult to satisfy highly linear operation for communication systems with wideband characteristics. The active phased array antenna systems with TWTAs require high power phase shifter and variable gain amplifier. It is not suitable for a transmitter that require small size [7]. GaN microwave monolithic integrated circuit (MMC) power amplifiers (PAs) can play a major role in the high linear operation as well as circuit-size reduction and cost reduction of solid-state power amplifiers (SSPAs) by replacing conventional TWTAs in mm-waves.

Figure 1 shows saturated output power versus frequency of device technologies [8].

Fig. 1  Saturated output power vs. frequency of device technologies [8].

This paper provides an overview of recent progress in GaN-HEMT modeling techniques and mm-wave GaN MMIC PAs for SATCOM and 5G mobile systems. Section 2 describes a large-signal GaN-HEMT model that incorporates trapping effects using an RC model and nonlinear capacitance. Section 3 presents the GaN MMIC PAs developed in K and Ka bands for the SATCOM system. In Sect. 4, the GaN Doherty MMIC PA developed for 5G mobile systems is described in detail. Finally, Sect. 5 concludes the paper.

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2. Large Signal GaN-HEMT Modeling Technique in Mm-Wave

To design GaN MMIC PAs, a large-signal model of GaN high electron mobility transistor (GaN-HEMT) with a high accuracy is required. Large-signal GaN-HEMT modeling techniques that take account of the trapping effects on the model as the drain current and transconductance have already been reported [9]–[11]. Additionally, it is important to take account of the trapping effects on the model as nonlinear capacitance in mm-wave band because it directly affects the amplitude modulation (AM) and phase modulation (PM) characteristics for SATCOM and 5G mobile systems amplifier design. In this section, a large-signal GaN-HEMT model that take account of the trapping effects on the model as nonlinear capacitance is described.

GaN-HEMT takes advantage of two-dimensional electron gas (2DEG) that is spontaneously formed between an aluminum gallium nitride (AlGaN) barrier and a GaN buffer. Figure 2 shows the simplified GaN-HEMT physical mechanisms of the proposed trap models under (a) direct current (DC) continuous condition and (b) DC pulsed condition [12]. Under the DC continuous condition, the gate is biased in the ON state, whereas the drain is continuously biased in the ON state under the low-voltage condition. However, in the pulsed condition, the gate and drain are immediately biased after the stress bias, which means that the gate voltage ($V_g$) is in the OFF state and the drain voltage ($V_d$) is high (30 to 50 V). The traps have a significant effect on the I-V and RF characteristics after stress bias because highly concentrated electrons are captured by traps owing to the strong electric field. As shown in Fig. 2, the drain current ($I_d$), gate-drain capacitance ($C_{gd}$), and drain-source resistance ($R_{ds}$) are strongly affected by the traps. That is, the acceptor-type traps at the GaN buffer layer are ionized by the capture of electrons after the stress bias; the concentration of 2DEG then decreases owing to the increased conduction band at the buffer layer. Consequently, $I_d$ and $C_{gd}$ decrease and $R_{ds}$ increases. Additionally, the ionized trap region expands to the drain side because of the high $V_d$, and $C_{gd}$ is considered to be more strongly affected by traps than the gate-source capacitance ($C_{gs}$).

Figure 3 shows a schematic of the proposed trap model. The Angelov-GaN model [13] was used as the fundamental large-signal model. As shown in Fig. 3, the trap circuit was loaded onto the drain terminal of the Angelov-GaN model. The trap circuit consists of a resistance ($R_{trap}$), capacitance ($C_{trap}$), and diode ($D_{trap}$). $R_{trap}$ is a large value that prevents the drain current from flowing through the ground. When the voltage at the drain terminal is excited by a sine wave, as shown in Fig. 3, $V_{trap}$ is the only DC component in the half-wave rectifier of the sine wave. In other words, the trap circuit operates as a detector. When the amplitude of the drain voltage is increased under a large-signal operation, $V_{trap}$ also increases. $V_{trap}$ is fed back to $C_{gd}$, $I_d$, and $g_m$. Figures 4a and 4b show the AM-AM and AM-PM characteristics at 28 GHz, respectively, to verify the proposed model. The dotted line represents the measured results, the solid line represents the simulated results using the proposed model, and the dotted line represents the simulated results using the conventional model. The conventional model is a general large-signal GaN-HEMT model that does not take account of the trapping effects on nonlinear capacitance. Therefore, the accuracy of AM-AM and AM-PM at saturated output operation is not good. As shown in Fig. 4, the proposed model is in good agreement with the measurements in both AM-AM and AM-PM characteristics.

3. GaN MMIC PA Technology Trend in K and Ka-Band for SATCOM System

Three GaN MMIC PAs that can be applied to the SATCOM system in the K and Ka-bands are described. Ta-
Table 1  Frequency Band of the SATCOM system

<table>
<thead>
<tr>
<th>SATCOM Frequency Band</th>
<th>Frequency Range</th>
<th>Band Width</th>
<th>Output Power/ PA</th>
<th>Application</th>
</tr>
</thead>
<tbody>
<tr>
<td>K-Band</td>
<td>17.3 – 21.2 GHz</td>
<td>3.9 GHz</td>
<td>&gt; 10 W</td>
<td>SATCOM downlink</td>
</tr>
<tr>
<td>Ka-Band</td>
<td>27.5 – 31.0 GHz</td>
<td>3.5 GHz</td>
<td>&gt; 10 W</td>
<td>SATCOM uplink</td>
</tr>
</tbody>
</table>

Table 1 lists the frequency bands of the SATCOM system. The SATCOM system is classified in two frequency bands, (a) 17.3 to 21.2 GHz (K-band) for downlink, fixed satellite services and broadcast satellite services, (b) 27.5 to 31.0 GHz (Ka-band) for uplink, SATCOM and 5G mobile systems. The GaN MMIC PA solution offers competitive advantages, because it can achieve a high linearity operation with wideband characteristics and high accuracy control of phase and amplitude far above the TWTAs. The transmitter modules of SSPAs consist of multiple PAs. In order to reduce the size of transmitter module, a PA is required with high output power density and high efficiency. GaN MMIC PAs meet the demand for both a small size and the high output power. However, an efficiency of GaN MMIC PAs has a trade-off relationship with the output power of that caused by a loss of inner power combiner networks, and the efficiency requirements depends on specifications of each SSPAs which is derived considering their thermal managements. In this section, GaN MMIC PAs with several output powers are introduced. First, a high output power K-band GaN MMIC PA compared with reported PAs [14]–[17] is described [18]. Second, 15 W and 32 W high output power density Ka-band GaN MMIC PAs compared with reported PAs [19]–[22] are explained [23], [24]. A high accuracy GaN-HEMT model is useful to design several output powers GaN MMIC PAs in a short term.

The GaN MMIC PA was fabricated utilizing a 0.15 µm gate length GaN process on a 50 µm thick SiC substrate with Individual Source Via (ISV) structure. Figure 5 shows a chip photograph of the fabricated K-band GaN MMIC PA [18]. The GaN MMIC PA consists of 3 stage Class-AB PAs. The number of gate fingers of the unit FET cell was 10 with unit gate width of 80 µm for the final stage. The final stage contained 8 FET cells, and 4 FET cells and 2 FET cells were used for the 2nd and 1st driver stage. Figure 6 shows the measured and simulated results of the input-output characteristics under continuous wave condition. The measured results were in good agreement with the simulated results. A maximum output power of 44.2 dBm (26 W) and maximum PAE of 32% were achieved with a power gain of over 25 dB at the best performing frequency. Figure 7 shows the measured performance over frequency. The junction temperature was estimated based on the calculated thermal resistance and the dissipation power was estimated based on the measured results of the output power and drain current of each stage. The junction temperature was approximately 170°C, which corresponded well with the simulated result. For wideband operation, the power amplifier realized an output power of 42.8 dBm (19 W), a PAE of over 26%, and a power gain of 25 dB over 17 to 21.4 GHz. Figure 8 shows the measurement results of adjacent channel power ratio (ACPR) and error vector magnitude (EVM). A modulation signal of 8-PSK (roff = 0.15, bandwidth = 10 MHz) was applied as a test signal, and a peak to average ratio (PAPR) of approxi-
approximately 8.4 dB. An average output power of 42.4 dBm, PAE of 28.9%, gain of 26.5 dB, EVM of 5.4%, and ACPR of −30 dBc were achieved. Table 2 shows the state-of-the-art of K-band GaN power amplifiers. The output power of the fabricated power amplifier is comparatively higher than other reported K-Band GaN MMIC PAs.

The Ka-band GaN MMIC PAs were also fabricated by the 0.15 μm gate length GaN process on a 50 μm thickness SiC substrate with the ISV structure. Figure 9 shows the chip photograph of the 15 W Ka-band GaN MMIC PA [23]. The GaN MMIC PAs consist of three stage Class-AB PAs. The number of gate finger of the unit FET cell was 8 with a 70 μm unit gate width for each stage. For the final stage, 4 FET cells were combined. Figure 10 shows the proposed inter stage matching network (ISMN) using the band-pass filter (BPF) configuration. The proposed ISMN consists of shunt inductors (L1, Lin1, Lin2), series capacitors (C2, C3) and transmission lines (TL4, TL5, TL6). The proposed ISMN divides an output transistor impedance of driver stage into two of input transistor impedance of the final stage. These circuit elements can be modified as an equivalent circuit of Butterworth BPF circuits. The proposed ISMN is designed with including the parasitic capacitances of the transistors for the final and driver stages. Figure 11 shows the simulated results of the proposed ISMN and a conventional ISMN using low-pass filter (LPF) configuration. The insertion loss of the proposed ISMN is lower than that of the conventional ISMN. Moreover, the proposed ISMN provides wider frequency response than the conventional ISMN. Consequently, a high efficiency and wideband Ka-band GaN MMIC PA was realized by applying the proposed ISMN. Figure 12 shows the measured input-output characteristics of 15 W GaN MMIC PA [23].
27 to 32% and gain of 20.0 to 22.0 dB were obtained over 26 to 31 GHz (FBW = 17.5%).

The output power of the Ka-band GaN MMIC PA shown in Fig. 9 is sufficient for replacing the TWTAs. There is a requirement for higher output power GaN MMIC PAs. Figure 14 shows a chip photograph of a 40 W Ka-band GaN MMIC PA [24]. The number of gate finger of the unit FET cell was 8 with a 80 µm unit gate width for each stage. In order to achieve high output power, 16 FET cells were combined at the final stage. The total gate width of this GaN MMIC PA approximately four times than that of the PA shown in Fig. 9. Figure 15 shows the measured input-output characteristics of the 40 W GaN MMIC PA. A measured maximum output power of 46.2 dBm, peak PAE of 30.2%, and gain of 18 dB were obtained under pulse operation (pulse period = 1 ms, pulse duty = 10%) at 28 GHz. Figure 16 shows the measured performance over frequency. The prototype of GaN MMIC PAs demonstrated output power of over 10 W with high efficiency at both K and Ka-bands required in the SATCOM system.

4. GaN MMIC PA Technology Trend in 5G Mm-Wave System

As mentioned in the Sect. 1, the Ka-band is also used in mm-wave 5G mobile systems. The base transceiver stations (BTSs) are classified into three categories depending on the equivalent isotropic radiation power (EIRP): (a) short range BTSs, which is used for in-room or hot spot high speed wireless connections, whose EIRP is less than 50 dBm; (b) middle range BTSs for high density urban areas and urban macro, whose EIRP is 50 to 60 dBm; and (c) long range

Table 3 State-of-the-art of a Ka-band GaN power amplifiers.

<table>
<thead>
<tr>
<th>Ref</th>
<th>Freq (GHz)</th>
<th>FBW (%)</th>
<th>Num. stage</th>
<th>Pout (dBm)</th>
<th>PAE (%)</th>
<th>Pd (W/mm²)</th>
</tr>
</thead>
<tbody>
<tr>
<td>[19]</td>
<td>27 - 31</td>
<td>13.8</td>
<td>3</td>
<td>39.0</td>
<td>44.7</td>
<td>2.02</td>
</tr>
<tr>
<td>[20]</td>
<td>27.5 - 31</td>
<td>12.0</td>
<td>3</td>
<td>42.1</td>
<td>42.5</td>
<td>2.32</td>
</tr>
<tr>
<td>[21]</td>
<td>26 - 30</td>
<td>13.8</td>
<td>2</td>
<td>46</td>
<td>36</td>
<td>2.94</td>
</tr>
<tr>
<td>[22]</td>
<td>28.5 - 31</td>
<td>15.7</td>
<td>3</td>
<td>46.2</td>
<td>25.9</td>
<td>2.37</td>
</tr>
<tr>
<td>[this work (23)]</td>
<td>26 - 31</td>
<td>17.5</td>
<td>3</td>
<td>41.8</td>
<td>32</td>
<td>3.85</td>
</tr>
<tr>
<td>[this work (24)]</td>
<td>26 - 31</td>
<td>17.5</td>
<td>3</td>
<td>46.2</td>
<td>30.2</td>
<td>2.58</td>
</tr>
</tbody>
</table>
BTSs, which is used for wireless back-haul connections in rural areas, whose EIRP is 60 to 70 dBm. For short range BTSs, an integrated silicon RF-IC solution is advantageous because it is generally inexpensive [25]. For the middle range BTSs, the GaAs MMIC solution can be used because the output power of the GaAs MMIC is 10 to 15 dB higher than that of silicon RF-ICs. For long range BTSs, a GaN solution is more likely to be adopted because its output power is far above that of the silicon RF-IC or GaAs MMIC [26].

Two types of beamforming antenna systems exist, as shown in Fig. 17 and Fig. 18. BTSs vendors have been considering expanding their sub-6 all-digital beamforming antenna system to be applied to mm-wave 5G mobile systems. An all-digital beamforming antenna system can realize many functions and high-accuracy control of massive multiple-input multiple-output beamforming. However, owing to the drastic increase in the channel bandwidth in mm-waves and the need for many active channel elements, there is a problem of power dissipation and cost. Therefore, BTSs vendors have proposed a sub-array hybrid-beamforming antenna system that combines analog and digital beamforming techniques [27]. It combines digital precoding and analog beamforming to simultaneously generate multiple beams in a single space, which allows flexibility between the number of baseband channels and the number of active RF channels. However, a sub-array hybrid-beamforming antenna system requires higher output power in Tx transmitter than all-digital beamforming Tx transmitter due to divide a Tx channel into multiple Tx channels. Therefore, high output power and high integrated transmitter is required to realize hybrid-beamforming antenna system.

Doherty power amplifier (DPA) technology has been used since 3G, 4G, and sub-6 5G BTSs, and new types of DPAs have been proposed [28]–[30]. However, it is difficult to achieve high efficiency and wideband characteristics owing to the large influence of parasitic elements in the mm-wave band. The frequency response of Doherty circuit configuration is limited by loaded Q factor which is derived from output impedance and output parasitic capacitance of transistors. In order to achieve high efficiency and wideband characteristics in mm-waves, Doherty circuit configuration that compensates output parasitic capacitance is required.

Figure 19 shows the chip photograph of the GaN Doherty MMIC PA, which was fabricated by the 0.15 μm gate length GaN process on the 50 μm thickness SiC substrate with the ISV structure [31]. Figure 20 shows the schematic of the impedance inverter formed by the Tee-network for the output combiner of the fabricated DPA. The Tee-network is formed by the $L_1$, $L_2$, $L_3$ and $C_{ds}$ of each transistor output parasitic capacitance. It operates as Doherty load modulation circuit by forming a impedance inverter. Figure 21 shows the measured (a) PAE and (b) Gain of fabricated DPA. As shown in Fig. 21, it was confirmed that the amplifier maintains the operation as a DPA in the wideband of 26 to 30 GHz. The DPA obtained output power of 36.1 to 36.5 dBm, a 6 dB and 8 dB output power back-off (OBO) PAE of 25 to 27%, 20.4 to 24.5%, and a peak PAE of 26.7 to 31.8%. To evaluate the linearity of the DPA, the ACPR and EVM were measured using the 64-QAM 45 MHz modulated signal with PAPR of 9.2 dB. Figure 22 shows the measured ACPR, EVM, and PAE over the frequency at average output power of 28 dBm. In the frequency of 26 to 30 GHz, the DPA achieved an ACPR lower than $-27$ dBc, EVM of 3.2 to 5.0%, and PAE of 20.1 to 23.8% at $P_{ave} = 28$ dBm. Table 4 shows comparison with the state-of-the-art of Ka-band GaN DPAs. To the best of authors’ knowledge, the performance of the fabricated DPA in this work is the widest bandwidth with the high efficiency in Ka-band.
5. Conclusion

This paper provides an overview of advances in a high accuracy large-signal GaN-HEMT modeling technique and GaN MMIC PAs for mm-wave applications on the basis of several published papers. The prototyped GaN PAs designed with the novel modeling technique has achieved good performances which are suitable to high power and high integration requirements of SATCOM and 5G mobile systems in mm-waves.

References


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